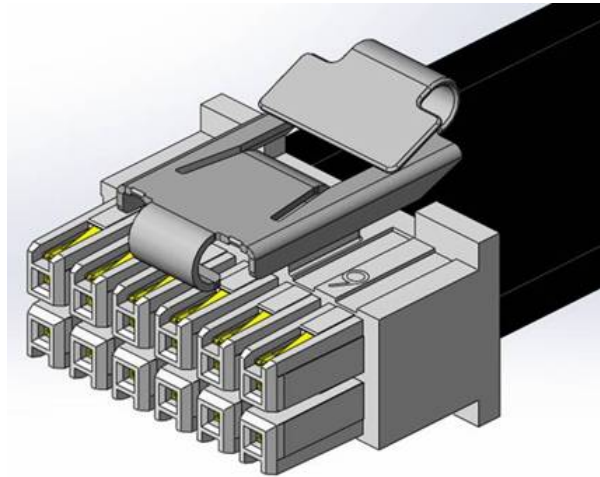
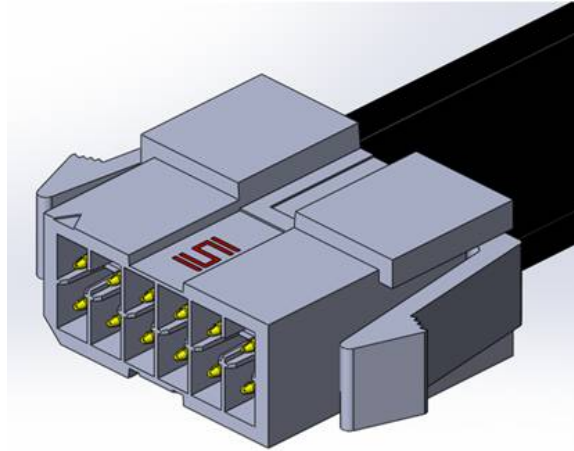




Project Number: Design Qualification Test Report	Tracking Code: 299779_Report_Rev_3
Requested by: Hardy Tain	Date: 12/12/2014
Part #: MRTD-08-20-L-03.00/MMSD-08-20-L-03.00-S-M	
Part description: MRTD/MMSD	Tech: Kason He
Test Start: 1/10/2014	Test Completed: 2/21/2014



(Actual part not depicted)

DESIGN QUALIFICATION TEST REPORT
MRTD/MMSD
MRTD-08-20-L-03.00/MMSD-08-20-L-03.00-S-M

REVISION HISTORY

DATA	REV.NUM.	DESCRIPTION	ENG
08/12/2014	1	Initial Issue	KH
12/12/2014	3	Update the part number	KH

CERTIFICATION

All instruments and measuring equipment were calibrated to National Institute for Standards and Technology (NIST) traceable standards according to ISO 10012-1 and ANSI/NCSL 2540-1, as applicable.

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SCOPE

To perform the following tests: Design Qualification test. Please see test plan.

APPLICABLE DOCUMENTS

Standards: EIA Publication 364

TEST SAMPLES AND PREPARATION

- 1) All materials were manufactured in accordance with the applicable product specification.
- 2) All test samples were identified and encoded to maintain traceability throughout the test sequences.
- 3) After soldering, the parts to be used for LLCR testing were cleaned according to TLWI-0001.
- 4) Either an automated cleaning procedure or an ultrasonic cleaning procedure may be used.
- 5) The automated procedure is used with aqueous compatible soldering materials.
- 6) Parts not intended for testing LLCR are visually inspected and cleaned if necessary.
- 7) Any additional preparation will be noted in the individual test sequences.
- 8) Solder Information: Lead Free
- 9) Samtec Test PCBs used: PCB-103826-TST/PCB-103827-TST

FLOWCHARTS

Mating/Unmating/Durability

Group 1

MRTD-08-20-L-06.00
MMSD-08-20-L-06.00-S-M
8 Assemblies

Note: Remove the latch to test mating&unmating force.

Step	Description
1.	LLCR ⁽²⁾ Max Delta = 15 mOhm
2.	Mating/Unmating Force ⁽³⁾
3.	Cycles Quantity = 25 Cycles
4.	Mating/Unmating Force ⁽³⁾
5.	Cycles Quantity = 25 Cycles
6.	Mating/Unmating Force ⁽³⁾
7.	Cycles Quantity = 25 Cycles
8.	Mating/Unmating Force ⁽³⁾
9.	Cycles Quantity = 25 Cycles
10.	Mating/Unmating Force ⁽³⁾
11.	LLCR ⁽²⁾ Max Delta = 15 mOhm
12.	Thermal Shock ⁽⁴⁾
13.	LLCR ⁽²⁾ Max Delta = 15 mOhm
14.	Humidity ⁽¹⁾
15.	LLCR ⁽²⁾ Max Delta = 15 mOhm
16.	Mating/Unmating Force ⁽³⁾

Group 2

MRTD-02-20-L-03.00
MMSD-02-20-L-03.00-S-M
8 Assemblies

Note: removing the latch.

Step	Description
1.	Mating/Unmating Force ⁽³⁾
2.	Cycles Quantity = 25 Cycles
3.	Mating/Unmating Force ⁽³⁾
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force ⁽³⁾
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force ⁽³⁾
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force ⁽³⁾

Group 3

MRTD-15-20-L-03.00
MMSD-15-20-L-03.00-S-M
8 Assemblies

Note: removing the latch.

Step	Description
1.	Mating/Unmating Force ⁽³⁾
2.	Cycles Quantity = 25 Cycles
3.	Mating/Unmating Force ⁽³⁾
4.	Cycles Quantity = 25 Cycles
5.	Mating/Unmating Force ⁽³⁾
6.	Cycles Quantity = 25 Cycles
7.	Mating/Unmating Force ⁽³⁾
8.	Cycles Quantity = 25 Cycles
9.	Mating/Unmating Force ⁽³⁾

- (1) Humidity = EIA-364-31
Test Condition = B (240 Hours)
Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)
Test Exceptions: ambient pre-condition and delete steps 7a and 7b
- (2) LLCR = EIA-364-23
Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max
- (3) Mating/Unmating Force = EIA-364-13
- (4) Thermal Shock = EIA-364-32
Exposure Time at Temperature Extremes = 1/2 Hour
Method A, Test Condition = I (-55°C to +85°C)
Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**IR/DWV****Pin-to-Pin**

<u>Group 1</u>		<u>Group 2</u>		<u>Group 3</u>		<u>Group 4</u>	
MRTD-08-20-L-03.00		MRTD-08-20-L-03.00		MMSD-08-20-L-03.00-S-M		MRTD-08-20-L-03.00	
MMSD-08-20-L-03.00-S-M						MMSD-08-20-L-03.00-S-M	
2 Assemblies		2 Assemblies		2 Assemblies		2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown(2)	1.	DWV Breakdown(2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

Row-to-Row

<u>Group 5</u>		<u>Group 6</u>		<u>Group 7</u>		<u>Group 8</u>	
MRTD-08-20-L-03.00		MRTD-08-20-L-03.00		MMSD-08-20-L-03.00-S-M		MRTD-08-20-L-03.00	
MMSD-08-20-L-03.00-S-M						MMSD-08-20-L-03.00-S-M	
2 Assemblies		2 Assemblies		2 Assemblies		2 Assemblies	
Step	Description	Step	Description	Step	Description	Step	Description
1.	DWV Breakdown (2)	1.	DWV Breakdown(2)	1.	DWV Breakdown (2)	1.	IR (4)
						2.	DWV at Test Voltage (1)
						3.	Thermal Shock (5)
						4.	IR (4)
						5.	DWV at Test Voltage (1)
						6.	Humidity (3)
						7.	IR (4)
						8.	DWV at Test Voltage (1)

(1) DWV at Test Voltage = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(2) DWV Breakdown = EIA-364-20

Test Condition = 1 (Sea Level)

DWV test voltage is equal to 75% of the lowest breakdown voltage

Test voltage applied for 60 seconds

(3) Humidity = EIA-364-31

Test Condition = B (240 Hours)

Test Method = III (+25°C to +65°C @ 90% RH to 98% RH)

Test Exceptions: ambient pre-condition and delete steps 7a and 7b

(4) IR = EIA-364-21

Test Condition = 500 Vdc, 2 Minutes Max

(5) Thermal Shock = EIA-364-32

Exposure Time at Temperature Extremes = 1/2 Hour

Method A, Test Condition = I (-55°C to +85°C)

Test Duration = A-3 (100 Cycles)

FLOWCHARTS Continued**Current Carrying Capacity**Group 1

MRTD-15-20-L-03.00
MMSD-15-20-L-03.00-S-M
2 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 2
Number of Positions = 1

Group 2

MRTD-15-20-L-03.00
MMSD-15-20-L-03.00-S-M
4 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 2
Number of Positions = 2

Group 3

MRTD-15-20-L-03.00
MMSD-15-20-L-03.00-S-M
6 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 2
Number of Positions = 3

Group 4

MRTD-15-20-L-03.00
MMSD-15-20-L-03.00-S-M
8 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 2
Number of Positions = 4

Group 5

MRTD-15-20-L-03.00
MMSD-15-20-L-03.00-S-M
30 Pins Powered
Signal

Step Description

1. CCC⁽¹⁾
Rows = 2
Number of Positions = 15

(1) CCC = EIA-364-70

Method 2, Temperature Rise Versus Current Curve

(TIN PLATING) - Tabulate calculated current at RT, 65°C, 75°C and 95°C after derating 20% and based on 105°C

(GOLD PLATING) - Tabulate calculated current at RT, 85°C, 95°C and 115°C after derating 20% and based on 125°C

Cable PullGroup 1

MRTD-08-20-L-03.00
MMSD-08-20-L-03.00-S-M
5 Assemblies
0 Degrees

Step Description

1. Cable Pull⁽¹⁾

Group 2

MRTD-08-20-L-03.00
MMSD-08-20-L-03.00-S-M
5 Assemblies
90 Degrees

Step Description

1. Cable Pull⁽¹⁾

(1) Cable Pull = EIA-364-38

Measure and Record Force Required to Failure

Failure = Discontinuity >1 microsecond at 10 ohms

FLOWCHARTS Continued**Mechanical Shock/Random Vibration/LLCR**Group 1

MRTD-08-20-L-12.00

MMSD-08-20-L-12.00-S-M

8 Assemblies

Step Description

1. LLCR ⁽¹⁾
Max Delta = 15 mOhm
2. Mechanical Shock ⁽²⁾
3. Random Vibration ⁽³⁾
4. LLCR ⁽¹⁾
Max Delta = 15 mOhm

(1) LLCR = EIA-364-23Open Circuit Voltage = 20 mV Max
Test Current = 100 mA Max

(2) Mechanical Shock = EIA-364-27

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)
Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(3) Random Vibration = EIA-364-28

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

Mechanical Shock/Random Vibration/Event DetectionGroup 1

MRTD-08-20-L-12.00

MMSD-08-20-L-12.00-S-M

60 Points

Step Description

1. Nanosecond Event Detection
(Mechanical Shock) ⁽¹⁾
2. Nanosecond Event Detection
(Random Vibration) ⁽²⁾

(1) Nanosecond Event Detection (Mechanical Shock)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-27 for Mechanical Shock:

Test Condition = C (100 G Peak, 6 milliseconds, Half Sine)

Number of Shocks = 3 Per Direction, Per Axis, 18 Total

(2) Nanosecond Event Detection (Random Vibration)

Use EIA-364-87 for Nanosecond Event Detection:

Test Condition = F (50 nanoseconds at 10 ohms)

Use EIA-364-28 for Random Vibration:

Condition = VB (7.56 gRMS Average, 2 Hours/Axis)

ATTRIBUTE DEFINITIONS

The following is a brief, simplified description of attributes.

THERMAL SHOCK:

- 1) EIA-364-32, *Thermal Shock (Temperature Cycling) Test Procedure for Electrical Connectors*.
- 2) Test Condition 1: -55°C to +85°C
- 3) Test Time: ½ hour dwell at each temperature extreme
- 4) Number of Cycles: 100
- 5) All test samples are pre-conditioned at ambient.
- 6) All test samples are exposed to environmental stressing in the mated condition.

HUMIDITY:

- 1) Reference document: EIA-364-31, *Humidity Test Procedure for Electrical Connectors*.
- 2) Test Condition B, 240 Hours.
- 3) Method III, +25° C to + 65° C, 90% to 98% Relative Humidity excluding sub-cycles 7a and 7b.
- 4) All samples are pre-conditioned at ambient.
- 5) All test samples are exposed to environmental stressing in the mated condition.

MECHANICAL SHOCK (Specified Pulse):

- 1) Reference document: EIA-364-27, *Mechanical Shock Test Procedure for Electrical Connectors*
- 2) Test Condition C
- 3) Peak Value: 100 G
- 4) Duration: 6 Milliseconds
- 5) Wave Form: Half Sine
- 6) Velocity: 12.3 ft/s
- 7) Number of Shocks: 3 Shocks / Direction, 3 Axis (18 Total)

MATING/UNMATING:

- 1) Reference document: EIA-364-13, *Mating and Unmating Forces Test Procedure for Electrical Connectors*.
- 2) The full insertion position was to within 0.003” to 0.004” of the plug bottoming out in the receptacle to prevent damage to the system under test.
- 3) One of the mating parts is secured to a floating X-Y table to prevent damage during cycling.

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) EIA-364-70, *Temperature Rise versus Current Test Procedure for Electrical Connectors and Sockets*.
- 2) When current passes through a contact, the temperature of the contact increases as a result of I^2R (resistive) heating.
- 3) The number of contacts being investigated plays a significant part in power dissipation and therefore temperature rise.
- 4) The size of the temperature probe can affect the measured temperature.
- 5) Copper traces on PC boards will contribute to temperature rise:
 - a. Self heating (resistive)
 - b. Reduction in heat sink capacity affecting the heated contacts
- 6) A de-rating curve, usually 20%, is calculated.
- 7) Calculated de-rated currents at three temperature points are reported:
 - a. Ambient
 - b. 65° C
 - c. 75° C
 - d. 95° C
- 8) Typically, neighboring contacts (in close proximity to maximize heat build up) are energized.
- 9) The thermocouple (or temperature measuring probe) will be positioned at a location to sense the maximum temperature in the vicinity of the heat generation area.
- 10) A computer program, *TR 803.exe*, ensures accurate stability for data acquisition.
- 11) Hook-up wire cross section is larger than the cross section of any connector leads/PC board traces, jumpers, etc.
- 12) Hook-up wire length is longer than the minimum specified in the referencing standard.

LLCR:

- 1) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 2) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 3) The following guidelines are used to categorize the changes in LLCR as a result from stressing
 - a. $\leq +5.0$ mOhms: ----- Stable
 - b. $+5.1$ to $+10.0$ mOhms:----- Minor
 - c. $+10.1$ to $+15.0$ mOhms: ----- Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: ----- Marginal
 - e. $+50.1$ to $+2000$ mOhms: ----- Unstable
 - f. $>+2000$ mOhms:----- Open Failure

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes.

INSULATION RESISTANCE (IR):

To determine the resistance of insulation materials to leakage of current through or on the surface of these materials when a DC potential is applied.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-21, *Insulation Resistance Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Electrification Time 2.0 minutes
 - iii. Test Voltage (500 VDC) corresponds to calibration settings for measuring resistances.
- 2) MEASUREMENTS:
- 3) When the specified test voltage is applied (VDC), the insulation resistance shall not be less than 1000 megohms.

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

To determine if the sockets can operate at its rated voltage and withstand momentary over potentials due to switching, surges, and other similar phenomenon. Separate samples are used to evaluate the effect of environmental stresses so not to influence the readings from arcing that occurs during the measurement process.

- 1) PROCEDURE:
 - a. Reference document: EIA-364-20, *Withstanding Voltage Test Procedure for Electrical Connectors*.
 - b. Test Conditions:
 - i. Between Adjacent Contacts or Signal-to-Ground
 - ii. Barometric Test Condition 1
 - iii. Rate of Application 500 V/Sec
 - iv. Test Voltage (VAC) until breakdown occurs
- 2) MEASUREMENTS/CALCULATIONS
 - a. The breakdown voltage shall be measured and recorded.
 - b. The dielectric withstanding voltage shall be recorded as 75% of the minimum breakdown voltage.
 - c. The working voltage shall be recorded as one-third (1/3) of the dielectric withstanding voltage (one-fourth of the breakdown voltage).

ATTRIBUTE DEFINITIONS Continued

The following is a brief, simplified description of attributes

CONNECTOR PULL:

- 1) Secure cable near center and pull on connector
 - a. At 90°, right angle to cable
 - b. At 0°, in-line with cable

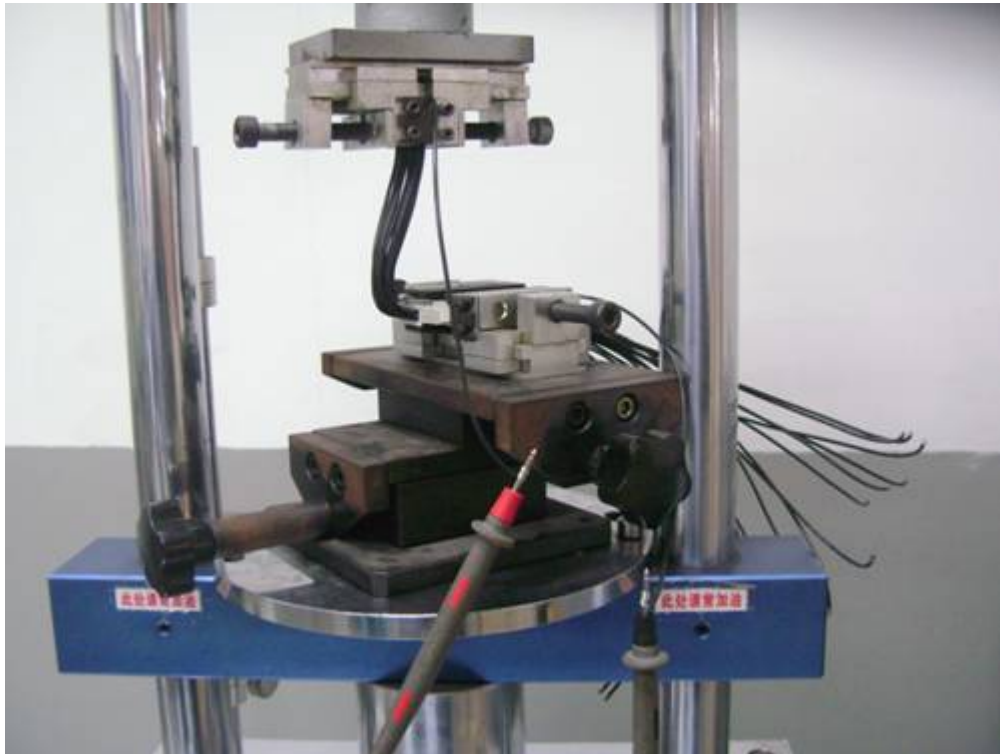


Fig. 1

(Typical set-up, actual part not depicted.)

90° Connector pull, notice the electrical continuity hook-up wires.

RESULTS

Temperature Rise, CCC at a 20% de-rating

- CCC for a 30°C Temperature Rise -----3.9 A per contact with 2 contacts (2 x 1) powered
- CCC for a 30°C Temperature Rise -----3.3 A per contact with 4 contacts (2 x 2) powered
- CCC for a 30°C Temperature Rise -----3.1 A per contact with 6 contacts (2 x 3) powered
- CCC for a 30°C Temperature Rise -----3.0 A per contact with 8 contacts (2 x 4) powered
- CCC for a 30°C Temperature Rise -----2.2 A per contact with 30 contacts (2 x 15) powered

Mating/Unmating Forces

Mating-Unmating Durability Group (MRTD-08-20-L-06.00/MMSD-08-20-L-06.00-S-M)

- **Initial**
 - **Mating**
 - Min ----- 1.27 Lbs
 - Max ----- 1.43 Lbs
 - **Unmating**
 - Min ----- 0.75 Lbs
 - Max ----- 0.90 Lbs
- **After 25 Cycles**
 - **Mating**
 - Min ----- 1.35 Lbs
 - Max ----- 1.51 Lbs
 - **Unmating**
 - Min ----- 0.80 Lbs
 - Max ----- 0.92 Lbs
- **After 50 Cycles**
 - **Mating**
 - Min ----- 1.42 Lbs
 - Max ----- 1.59 Lbs
 - **Unmating**
 - Min ----- 0.82 Lbs
 - Max ----- 0.98 Lbs
- **After 75 Cycles**
 - **Mating**
 - Min ----- 1.47 Lbs
 - Max ----- 1.70 Lbs
 - **Unmating**
 - Min ----- 0.91 Lbs
 - Max ----- 1.02 Lbs
- **After 100 Cycles**
 - **Mating**
 - Min ----- 1.52 Lbs
 - Max ----- 1.74 Lbs
 - **Unmating**
 - Min ----- 0.95 Lbs
 - Max ----- 1.11 Lbs
- **Humidity**
 - **Mating**
 - Min ----- 1.49 Lbs
 - Max ----- 2.25 Lbs
 - **Unmating**
 - Min ----- 0.57 Lbs
 - Max ----- 0.85 Lbs

RESULTS Continued**Mating/Unmating Forces****Mating-Unmating Basic (MRTD-02-20-L-03.00/MMSD-02-20-L-03.00-S-M)**

- **Initial**
 - **Mating**
 - **Min** ----- 0.25 Lbs
 - **Max** ----- 0.47 Lbs
 - **Unmating**
 - **Min** ----- 0.13 Lbs
 - **Max** ----- 0.22 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 0.28 Lbs
 - **Max** ----- 0.47 Lbs
 - **Unmating**
 - **Min** ----- 0.15 Lbs
 - **Max** ----- 0.21 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 0.31 Lbs
 - **Max** ----- 0.47 Lbs
 - **Unmating**
 - **Min** ----- 0.15 Lbs
 - **Max** ----- 0.24 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 0.31 Lbs
 - **Max** ----- 0.49 Lbs
 - **Unmating**
 - **Min** ----- 0.17 Lbs
 - **Max** ----- 0.23 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 0.32 Lbs
 - **Max** ----- 0.50 Lbs
 - **Unmating**
 - **Min** ----- 0.16 Lbs
 - **Max** ----- 0.24 Lbs

RESULTS Continued**Mating/Unmating Forces****Mating-Unmating Basic (MRTD-15-20-L-03.00/MMSD-15-20-L-03.00-S-M)**

- **Initial**
 - **Mating**
 - **Min** ----- 1.53 Lbs
 - **Max** ----- 2.20 Lbs
 - **Unmating**
 - **Min** ----- 0.76 Lbs
 - **Max** ----- 1.23 Lbs
- **After 25 Cycles**
 - **Mating**
 - **Min** ----- 1.78 Lbs
 - **Max** ----- 2.53 Lbs
 - **Unmating**
 - **Min** ----- 0.86 Lbs
 - **Max** ----- 1.39 Lbs
- **After 50 Cycles**
 - **Mating**
 - **Min** ----- 1.96 Lbs
 - **Max** ----- 2.74 Lbs
 - **Unmating**
 - **Min** ----- 1.02 Lbs
 - **Max** ----- 1.59 Lbs
- **After 75 Cycles**
 - **Mating**
 - **Min** ----- 2.13 Lbs
 - **Max** ----- 2.91 Lbs
 - **Unmating**
 - **Min** ----- 1.44 Lbs
 - **Max** ----- 1.81 Lbs
- **After 100 Cycles**
 - **Mating**
 - **Min** ----- 2.23 Lbs
 - **Max** ----- 3.12 Lbs
 - **Unmating**
 - **Min** ----- 1.25 Lbs
 - **Max** ----- 1.89 Lbs

RESULTS Continued**Insulation Resistance minimums, IR**

- **Initial**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated ----- 10000 Meg Ω ----- Passed
- **Thermal Shock**
 - Mated----- 10000 Meg Ω ----- Passed
 - Unmated ----- 10000 Meg Ω ----- Passed
- **Humidity**
 - Mated-----10000 Meg Ω ----- Passed
 - Unmated -----10000 Meg Ω ----- Passed

Dielectric Withstanding Voltage minimums, DWV

- **Minimums**
 - Breakdown Voltage----- 1750 VAC
 - Test Voltage ----- 1313 VAC
 - Working Voltage ----- 435 VAC
- **Initial DWV**-----Passed
- **Thermal DWV**-----Passed
- **Humidity DWV**-----Passed

RESULTS Continued**LLCR Mating/Unmating Durability Group (128 LLCR test points)**

- **Initial** ----- 20.12 mOhms Max
- **Durability, 100 Cycles**
 - **<= +5.0 mOhms** ----- 128 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Thermal Shock**
 - **<= +5.0 mOhms** ----- 128 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure
- **Humidity**
 - **<= +5.0 mOhms** ----- 128 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 0 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure

LLCR Shock & Vibration Group (128 LLCR test points)

- **Initial** ----- 32.90 mOhms Max
- **Shock & Vibration**
 - **<= +5.0 mOhms** ----- 127 Points ----- Stable
 - **+5.1 to +10.0 mOhms** ----- 1 Points ----- Minor
 - **+10.1 to +15.0 mOhms** ----- 0 Points ----- Acceptable
 - **+15.1 to +50.0 mOhms** ----- 0 Points ----- Marginal
 - **+50.1 to +2000 mOhms** ----- 0 Points ----- Unstable
 - **>+2000 mOhms** ----- 0 Points ----- Open Failure

Cable Pull

- **0 ° Pull force**
 - **Min** ----- 13.19 Lbs
 - **Max** ----- 15.88 Lbs
- **90 ° Pull force**
 - **Min** ----- 12.80 Lbs
 - **Max** ----- 15.42 Lbs

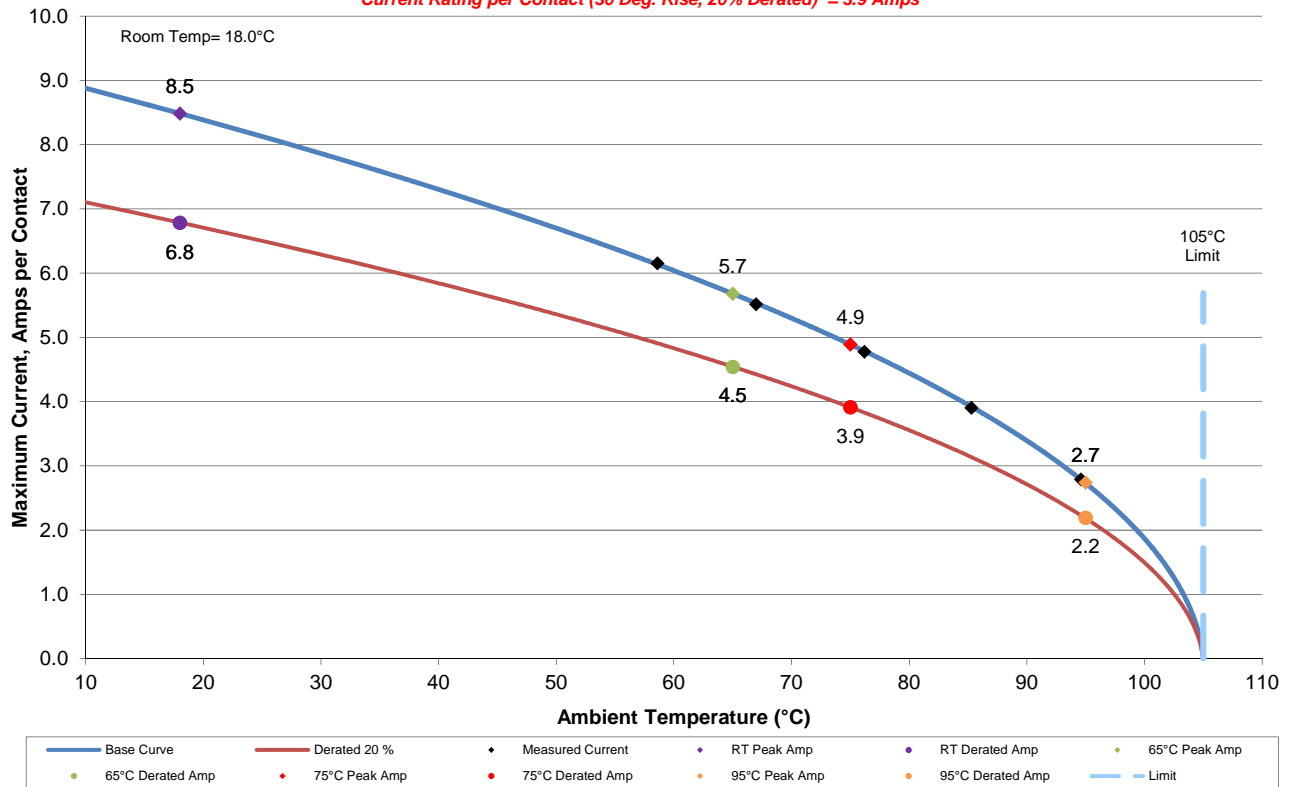
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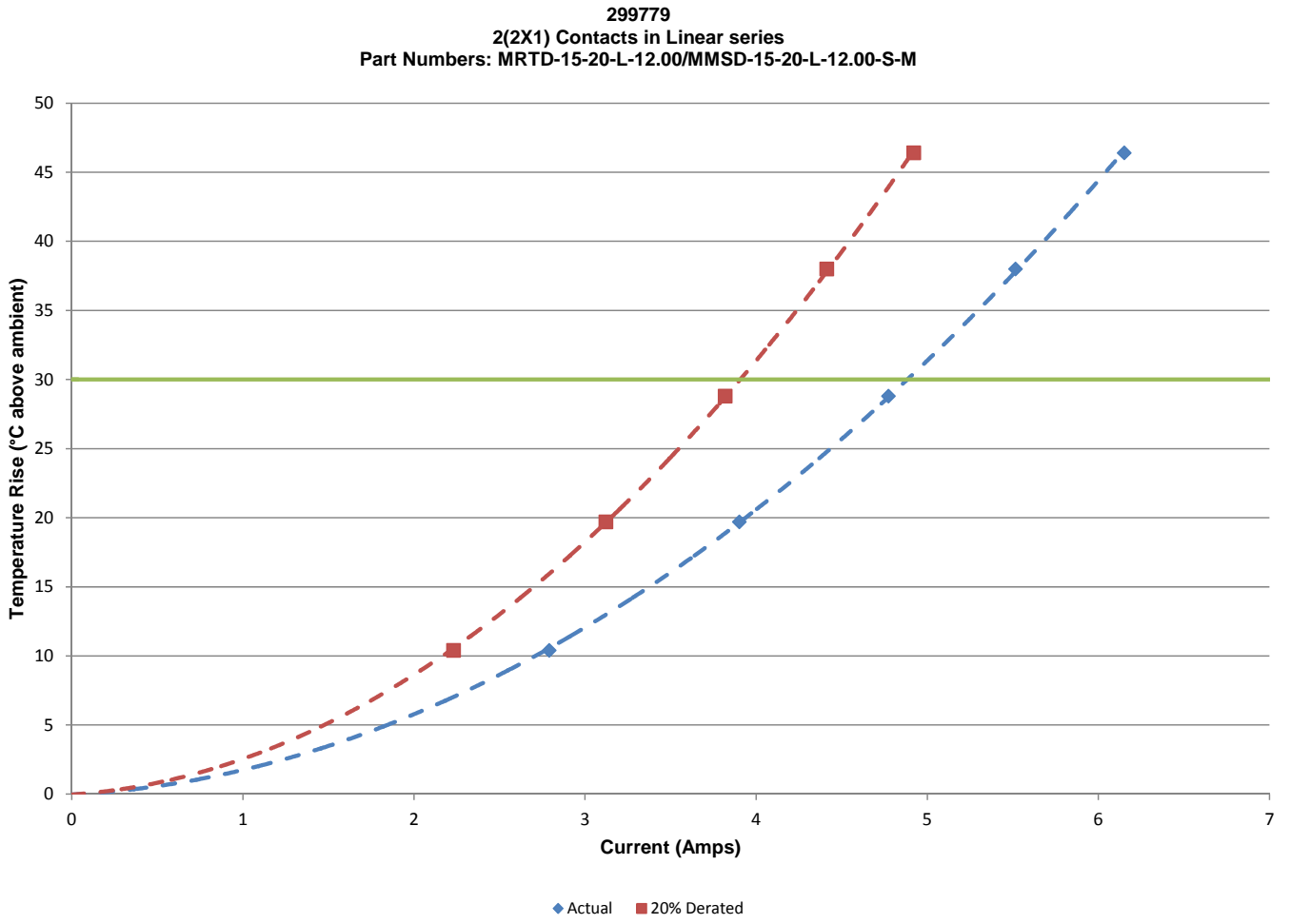
TEMPERATURE RISE (Current Carrying Capacity, CCC):

- 1) High quality thermocouples whose temperature slopes track one another were used for temperature monitoring.
- 2) The thermocouples were placed at a location to sense the maximum temperature generated during testing.
- 3) Temperature readings recorded are those for which three successive readings, 15 minutes apart, differ less than 1° C (computer controlled data acquisition).
- 4) Adjacent contacts were powered:
 - a. Linear configuration with 2 adjacent conductors/contacts powered

299779
2(2X1) Contacts in Linear series
Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 3.9 Amps



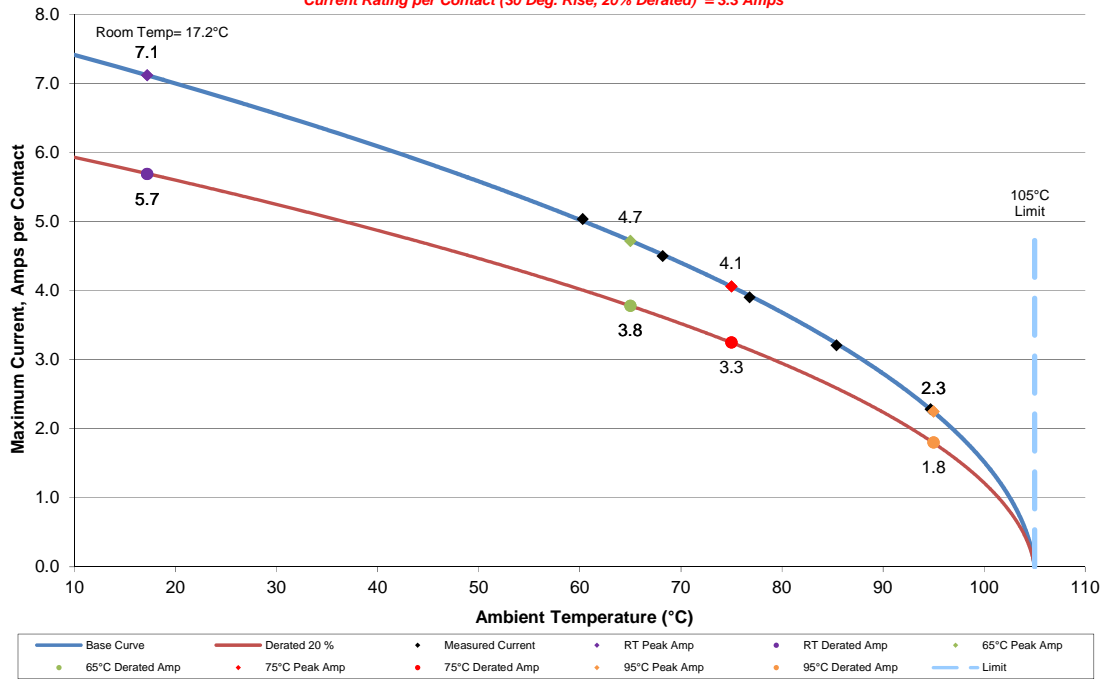


DATA SUMMARIES Continued

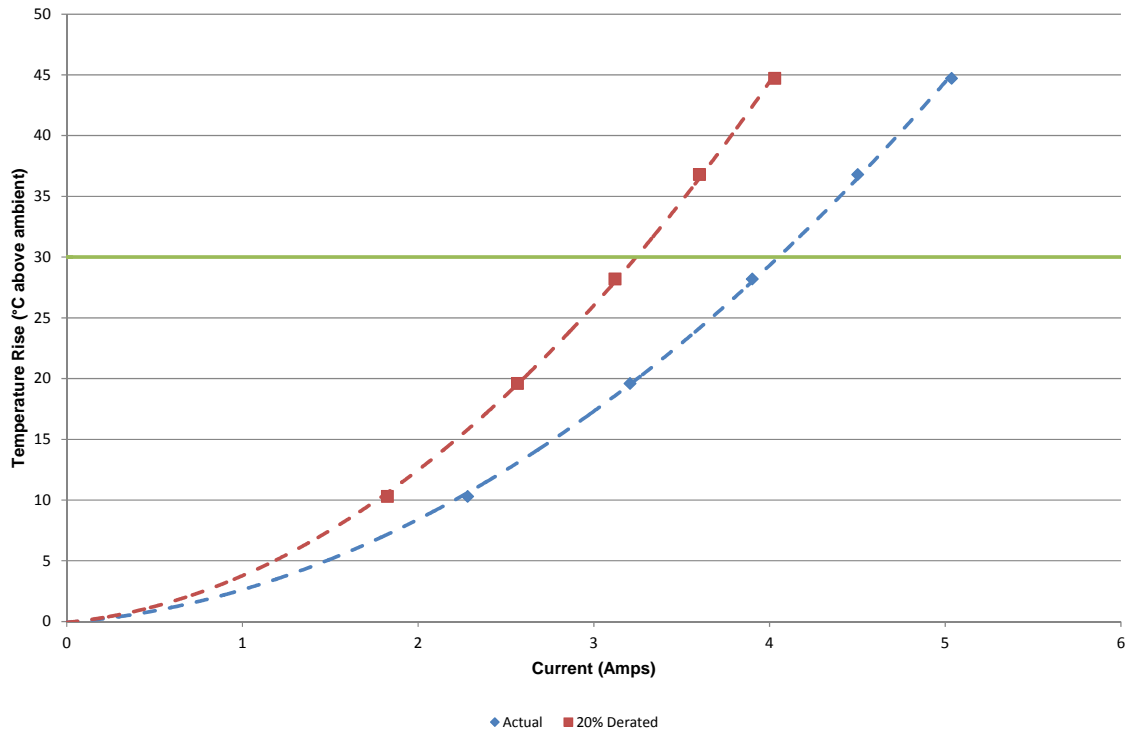
b. Linear configuration with 4 adjacent conductors/contacts powered

299779
 4(2X2) Contacts in Linear series
 Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 3.3 Amps



299779
 4(2X2) Contacts in Linear series
 Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M

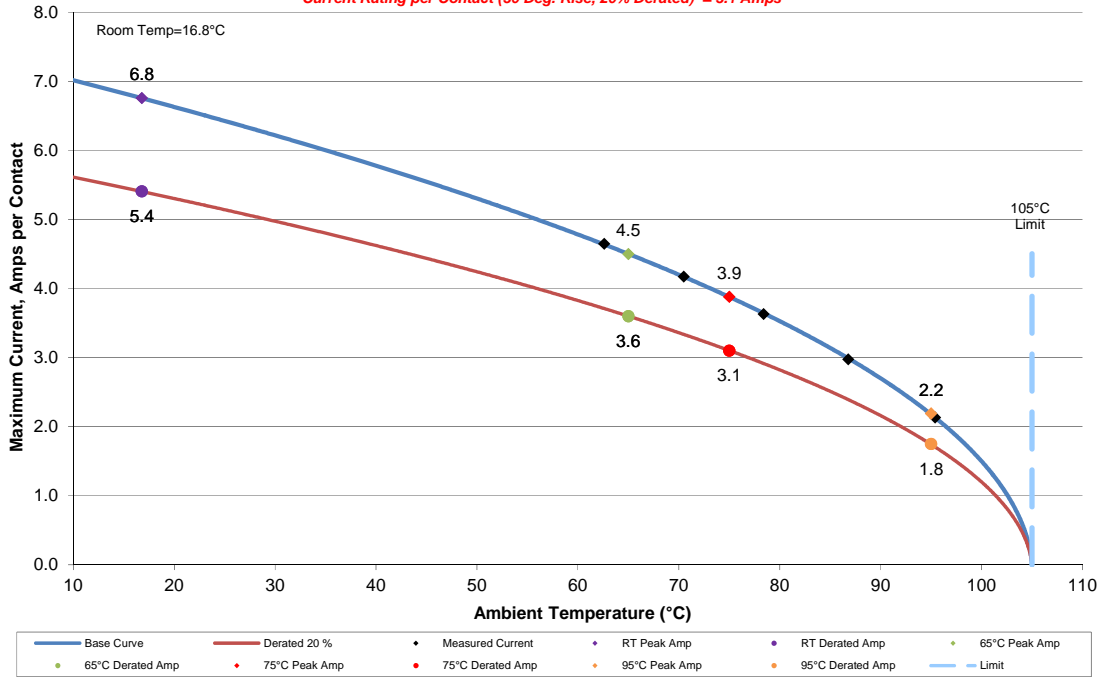


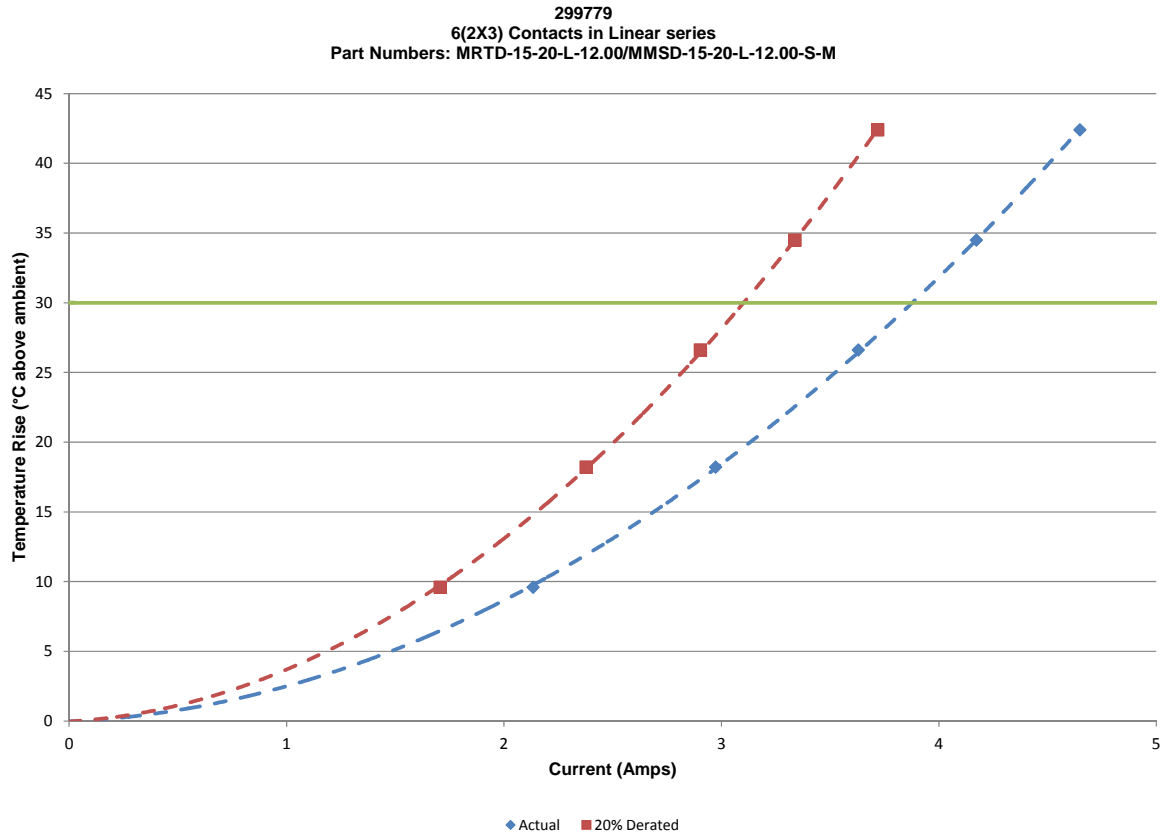
DATA SUMMARIES Continued

c. Linear configuration with 6 adjacent conductors/contacts powered

299779
 6(2X3) Contacts in Linear series
 Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 3.1 Amps



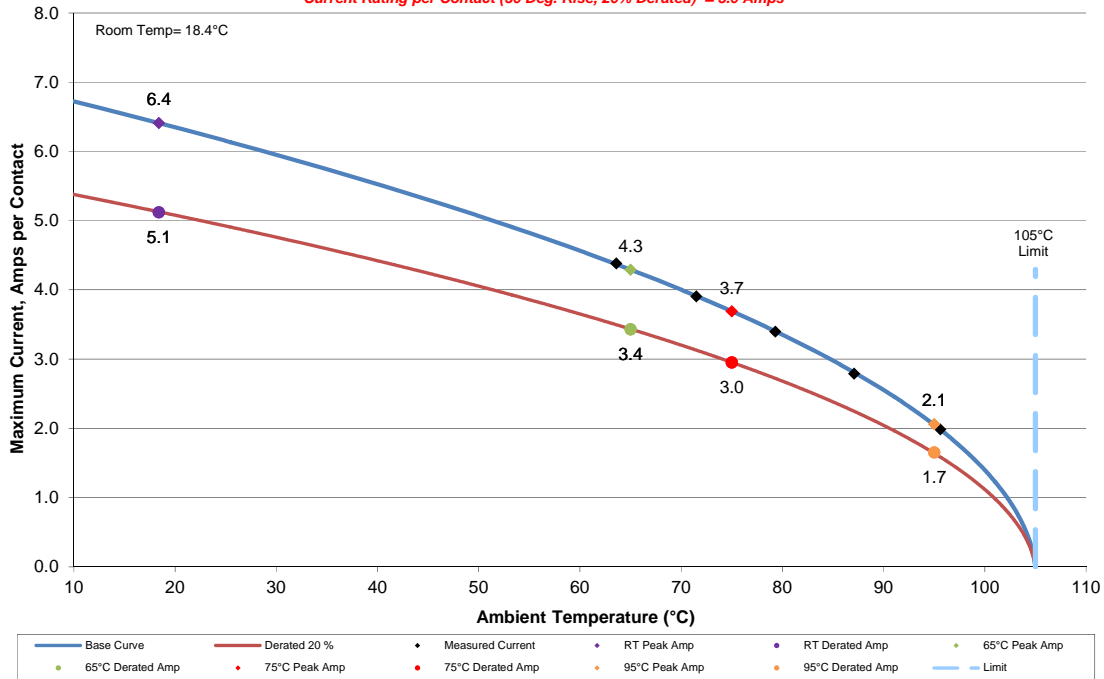


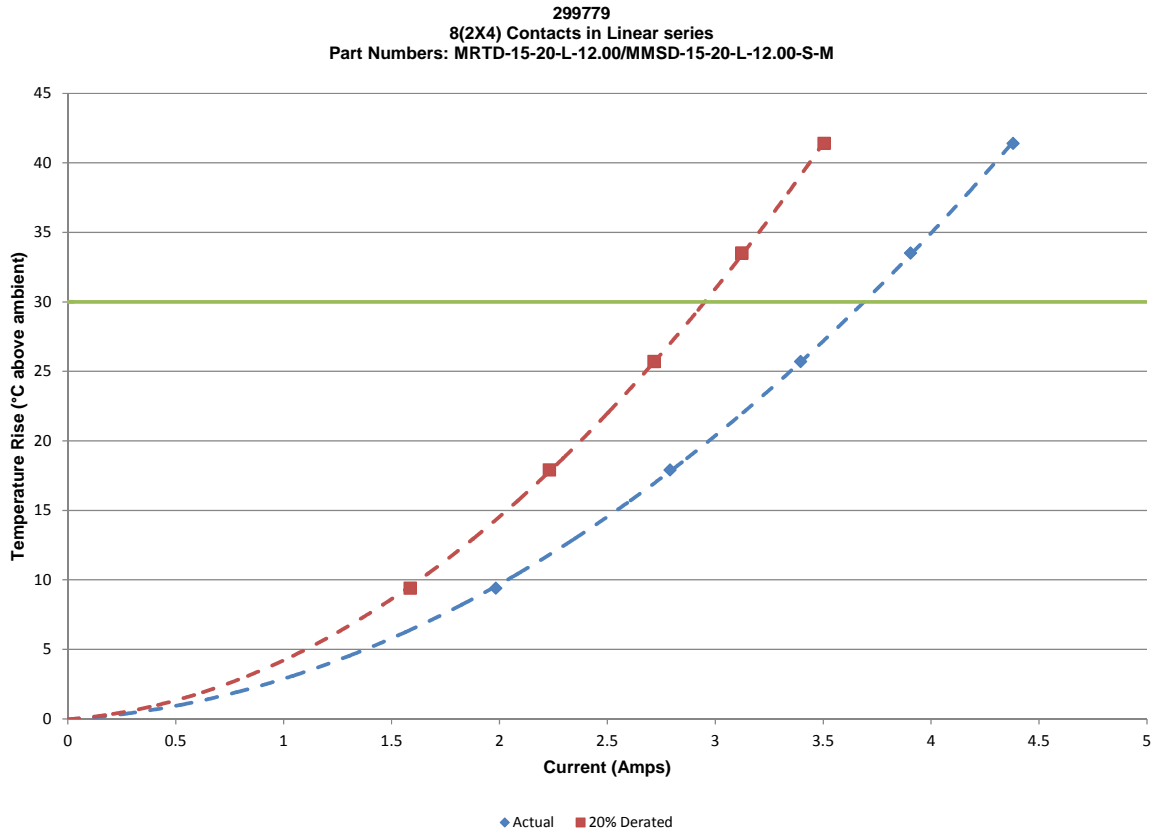
DATA SUMMARIES Continued

d. Linear configuration with 8 adjacent conductors/contacts powered

299779
 8(2X4) Contacts in Linear series
 Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 3.0 Amps



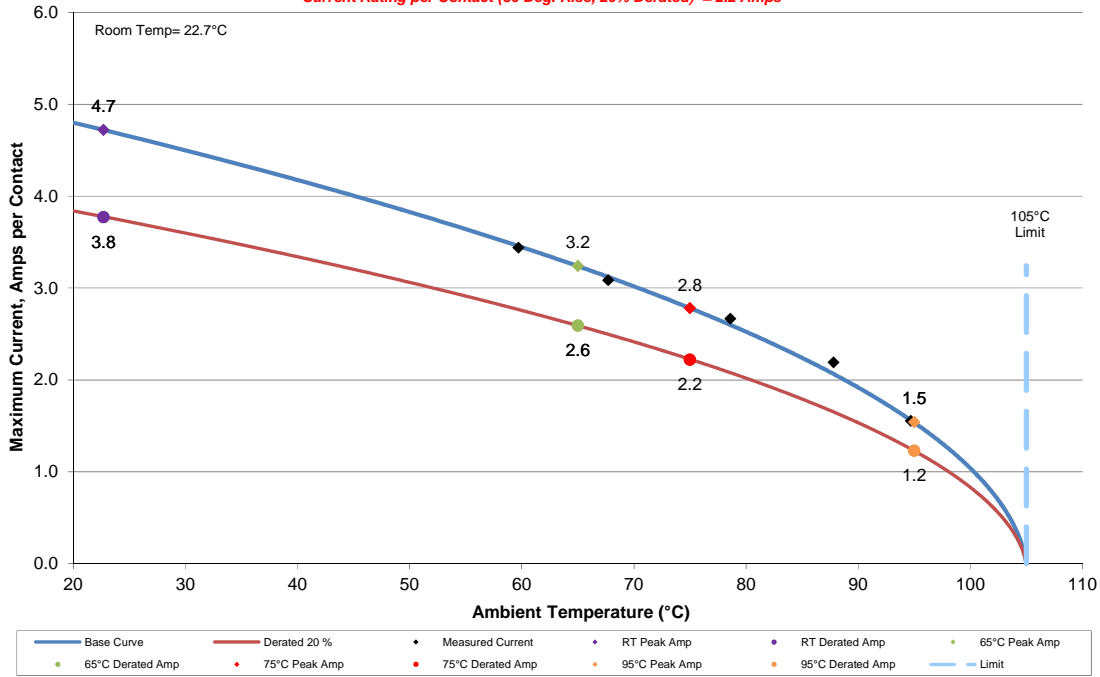


DATA SUMMARIES Continued

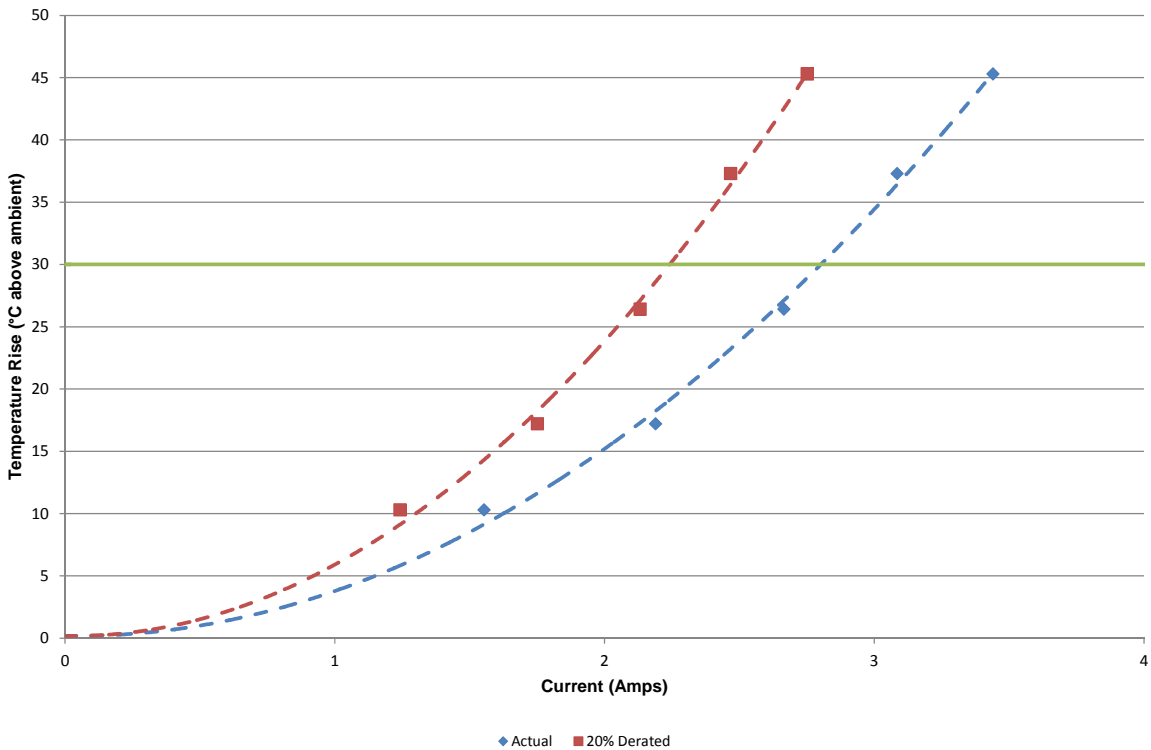
e. Linear configuration with all adjacent conductors/contacts powered

299779
 30(All) Contacts in Linear series
 Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M

Current Rating per Contact (30 Deg. Rise, 20% Derated) = 2.2 Amps



299779
 30(All) Contacts in Linear series
 Part Numbers: MRTD-15-20-L-12.00/MMSD-15-20-L-12.00-S-M



DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Mating-Unmating Durability Group (MRTD-08-20-L-06.00/MMSD-08-20-L-06.00-S-M)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	New tons	Force (Lbs)	New tons	Force (Lbs)	New tons	Force (Lbs)	New tons	Force (Lbs)
Minimum	5.65	1.27	3.34	0.75	6.00	1.35	3.56	0.80
Maximum	6.36	1.43	4.00	0.90	6.72	1.51	4.09	0.92
Average	6.11	1.37	3.70	0.83	6.41	1.44	3.75	0.84
St Dev	0.22	0.05	0.20	0.05	0.24	0.05	0.15	0.03
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	New tons	Force (Lbs)	New tons	Force (Lbs)	New tons	Force (Lbs)	New tons	Force (Lbs)
Minimum	6.32	1.42	3.65	0.82	6.54	1.47	4.05	0.91
Maximum	7.07	1.59	4.36	0.98	7.56	1.70	4.54	1.02
Average	6.69	1.50	3.96	0.89	6.97	1.57	4.21	0.95
St Dev	0.26	0.06	0.20	0.04	0.34	0.08	0.15	0.03
Count	8	8	8	8	8	8	8	8
	After 100 Cycles				After Humidity			
	Mating		Unmating		Mating		Unmating	
	New tons	Force (Lbs)	New tons	Force (Lbs)	New tons	Force (Lbs)	New tons	Force (Lbs)
Minimum	6.76	1.52	4.23	0.95	6.63	1.49	2.54	0.57
Maximum	7.74	1.74	4.94	1.11	10.01	2.25	5.83	1.31
Average	7.26	1.63	4.46	1.00	8.42	1.89	3.76	0.85
St Dev	0.33	0.07	0.23	0.05	1.34	0.30	0.95	0.21
Count	8	8	8	8	8	8	8	8

DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Mating-Unmating Basic (MRTD-02-20-L-03.00/MMSD-02-20-L-03.00-S-M)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)
Minimum	1.11	0.25	0.58	0.13	1.25	0.28	0.67	0.15
Maximum	2.09	0.47	0.98	0.22	2.09	0.47	0.93	0.21
Average	1.47	0.33	0.75	0.17	1.63	0.37	0.76	0.17
St Dev	0.33	0.07	0.13	0.03	0.27	0.06	0.10	0.02
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)	Newton	Force (Lbs)
Minimum	1.38	0.31	0.67	0.15	1.38	0.31	0.76	0.17
Maximum	2.09	0.47	1.07	0.24	2.18	0.49	1.02	0.23
Average	1.67	0.38	0.84	0.19	1.74	0.39	0.87	0.20
St Dev	0.24	0.06	0.12	0.03	0.29	0.06	0.10	0.02
Count	8	8	8	8	8	8	8	8
	After 100 Cycles							
	Mating		Unmating					
	Newton	Force (Lbs)	Newton	Force (Lbs)				
Minimum	1.42	0.32	0.71	0.16				
Maximum	2.22	0.50	1.07	0.24				
Average	1.82	0.41	0.87	0.20				
St Dev	0.27	0.06	0.11	0.03				
Count	8	8	8	8				

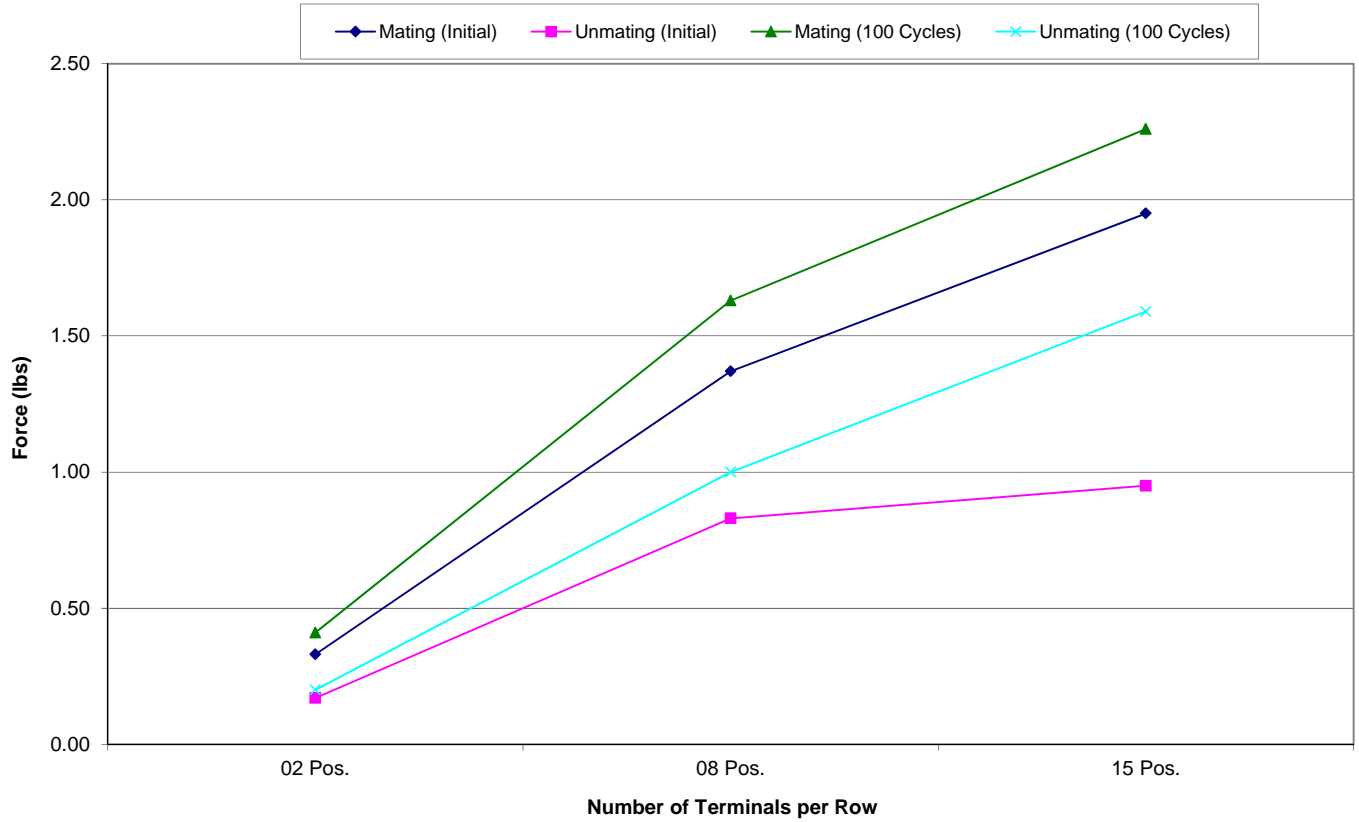
DATA SUMMARIES Continued**MATING-UNMATING FORCE:****Mating-Unmating Basic (MRTD-15-20-L-03.00/MMSD-15-20-L-03.00-S-M)**

	Initial				After 25 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	6.81	1.53	3.38	0.76	7.92	1.78	3.83	0.86
Maximum	9.79	2.20	5.47	1.23	11.25	2.53	6.18	1.39
Average	8.68	1.95	4.23	0.95	9.88	2.22	5.10	1.15
St Dev	0.91	0.20	0.69	0.15	0.97	0.22	0.76	0.17
Count	8	8	8	8	8	8	8	8
	After 50 Cycles				After 75 Cycles			
	Mating		Unmating		Mating		Unmating	
	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)	Newton's	Force (Lbs)
Minimum	8.72	1.96	4.54	1.02	9.47	2.13	5.07	1.14
Maximum	12.19	2.74	7.07	1.59	12.94	2.91	8.05	1.81
Average	10.90	2.45	5.88	1.32	11.66	2.62	6.48	1.46
St Dev	1.08	0.24	0.80	0.18	1.06	0.24	0.90	0.20
Count	8	8	8	8	8	8	8	8
	After 100 Cycles							
	Mating		Unmating					
	Newton's	Force (Lbs)	Newton's	Force (Lbs)				
Minimum	9.92	2.23	5.56	1.25				
Maximum	13.88	3.12	8.41	1.89				
Average	12.29	2.76	7.05	1.59				
St Dev	1.15	0.26	0.91	0.20				
Count	8	8	8	8				

DATA SUMMARIES Continued

Mating\Unmating Force Comparison

Mating/Unmating Data for 02, 08 and 15 Position MRTD/MMSD



DATA SUMMARIES Continued**INSULATION RESISTANCE (IR):**

	Pin to Pin		
	Mated	Unmated	Unmated
Minimum	MRTD/MMSD	MRTD	MMSD
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

	Row to Row		
	Mated	Unmated	Unmated
Minimum	MRTD/MMSD	MRTD	MMSD
Initial	10000	10000	10000
Thermal	10000	10000	10000
Humidity	10000	10000	10000

DIELECTRIC WITHSTANDING VOLTAGE (DWV):

Voltage Rating Summary	
Minimum	MRTD/MMSD
Break Down Voltage	1750
Test Voltage	1313
Working Voltage	435
Pin to Pin	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed
Row to Row	
Initial Test Voltage	Passed
After Thermal Test Voltage	Passed
After Humidity Test Voltage	Passed

DATA SUMMARIES Continued**LLCR Mating/Unmating Durability Group**

- 1). A total of 128 points were measured.
- 2). EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3). A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4). The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms: -----Stable
 - b. $+5.1$ to $+10.0$ mOhms: -----Minor
 - c. $+10.1$ to $+15.0$ mOhms: -----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms: -----Marginal
 - e. $+50.1$ to $+2000$ mOhms -----Unstable
 - f. $> +2000$ mOhms: -----Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014-1-10	2014-1-13	2014-1-21	2014-2-21
Room Temp (Deg C)	20	19	19	18
Rel Humidity (%)	42	42	25	42
Technician	Kason He	Kason He	Kason He	Kason He
mOhm values	Actual Initial	Delta 100 Cycles	Delta Therm Shck	Delta Humidity
Pin Type 1: Signal				
Average	18.19	0.59	0.54	0.62
St. Dev.	0.65	0.49	0.49	0.53
Min	16.44	0.00	0.00	0.01
Max	20.12	2.06	2.33	2.54
Summary Count	128	128	128	128
Total Count	128	128	128	128

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	$>5 \ \& \ \leq 10$	$>10 \ \& \ \leq 15$	$>15 \ \& \ \leq 50$	$>50 \ \& \ \leq 1000$	>1000
100 Cycles	128	0	0	0	0	0
Therm Shck	128	0	0	0	0	0
Humidity	128	0	0	0	0	0

DATA SUMMARIES Continued

LLCR Shock & Vibration Group

- 1) A total of 128 points were measured.
- 2) EIA-364-23, *Low Level Contact Resistance Test Procedure for Electrical Connectors and Sockets*.
- 3) A computer program, *LLCR 221.exe*, ensures repeatability for data acquisition.
- 4) The following guidelines are used to categorize the changes in LLCR as a result from stressing.
 - a. $\leq +5.0$ mOhms:-----Stable
 - b. $+5.1$ to $+10.0$ mOhms:-----Minor
 - c. $+10.1$ to $+15.0$ mOhms:-----Acceptable
 - d. $+15.1$ to $+50.0$ mOhms:-----Marginal
 - e. $+50.1$ to $+2000$ mOhms-----Unstable
 - f. $>+2000$ mOhms:-----Open Failure

LLCR Measurement Summaries by Pin Type				
Date	2014-7-21	2014-7-24		
Room Temp (Deg C)	22	22		
Rel Humidity (%)	42	40		
Technician	Aaron McKim	Aaron McKim		
mOhm values	Actual	Delta	Delta	Delta
	Initial	Shock-Vib		
Pin Type 1: Signal				
Average	28.10	0.88		
St. Dev.	0.97	0.72		
Min	26.23	0.03		
Max	32.90	5.22		
Summary Count	128	128		
Total Count	128	128		

LLCR Delta Count by Category						
	Stable	Minor	Acceptable	Marginal	Unstable	Open
mOhms	≤ 5	>5 & ≤ 10	>10 & ≤ 15	>15 & ≤ 50	>50 & ≤ 1000	>1000
Shock-Vib	127	1	0	0	0	0

DATA SUMMARIES Continued**Cable Pull****0 ° Pull force**

	Force (lbs)
Minimum	13.19
Maximum	15.88
Average	14.51

90 ° Pull force

	Force (lbs)
Minimum	12.80
Maximum	15.42
Average	13.59

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** HZ-TCT-01**Description:** Normal force analyzer**Manufacturer:** Mecmesin Multitester**Model:** Mecmesin Multitester 2.5-i**Serial #:** 08-1049-04**Accuracy:** Last Cal: 4/26/2013, Next Cal: 4/25/2014**Equipment #:** HZ-THC-01**Description:** Humidity transmitter**Manufacturer:** Thermtron**Model:** SM-8-8200**Serial #:** 38846**Accuracy:** Last Cal: 2/28/2013, Next Cal: 2/27/2014**Equipment #:** HZ-HPM-01**Description:** NA9636H**Manufacturer:** Ainuo**Model:** 6031A**Serial #:** 089601091**Accuracy:** Last Cal: 3/7/2013, Next Cal: 3/6/2014**Equipment #:** HZ-MO-05**Description:** Micro-ohmmeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 1285188**Accuracy:** Last Cal: 11/14/2013, Next Cal: 11/13/2014**Equipment #:** HZ-TSC-01**Description:** Vertical Thermal Shock Chamber**Manufacturer:** Cincinnatti Sub Zero**Model:** VTS-3-6-6-SC/AC**Serial #:** 10-VT14994**Accuracy:** See Manual

... Last Cal: 06/27/2013, Next Cal: 06/26/2014

Equipment #: HZ-PS-01**Description:** 120 Amp Power Supply**Manufacturer:** Agilent**Model:** 6031A PS**Serial #:** MY41000982**Accuracy:** See Manual

... Last Cal: 07/02/2013, Next Cal: 07/01/2014

Equipment #: HZ-MO-01**Description:** Multimeter /Data Acquisition System**Manufacturer:** Keithley**Model:** 2700**Serial #:** 1199807**Accuracy:** See Manual

... Last Cal: 07/02/2013, Next Cal: 07/01/2014

EQUIPMENT AND CALIBRATION SCHEDULES**Equipment #:** MO-11**Description:** Switch/Multimeter**Manufacturer:** Keithley**Model:** 3706**Serial #:** 120169**Accuracy:** See Manual

... Last Cal: 08/21/2013, Next Cal: 08/21/2014

Equipment #: SVC-01**Description:** Shock & Vibration Table**Manufacturer:** Data Physics**Model:** LE-DSA-10-20K**Serial #:** 10037**Accuracy:** See Manual

... Last Cal: 11/31/2013, Next Cal: 11/31/2014